## **ECE 3040 Microelectronic Circuits**

Exam 1

February 15, 2019

Dr. W. Alan Doolittle

20 minutes

Print your name clearly and largely:

52/usions

Instructions: <u>DO NOT REMOVE ANY SHEETS FROM THIS EXAM!</u> Read all the problems carefully and thoroughly before you begin working. You are allowed to use 1 sheet of notes (1 page front and back) as well as a calculator. There are 100 total points. Observe the point value of each problem and allocate your time accordingly. SHOW ALL WORK AND CIRCLE YOUR FINAL ANSWER WITH THE PROPER UNITS INDICATED. <u>Write</u> <u>legibly</u>. If I cannot read it, it will be considered a wrong answer. Do all work on the paper provided. Turn in all scratch paper, even if it did not lead to an answer. Turn in your notes sheet placed under your exam. Report any and all ethics violations to the instructor. A periodic table is supplied on the last page. Good luck!

Sign your name on **ONE** of the two following cases:

I DID NOT observe any ethical violations during this exam:

I observed an ethical violation during this exam:

## First 30% Multiple Choice and True/False (Circle the letter of the most correct <u>answer or answers</u>)

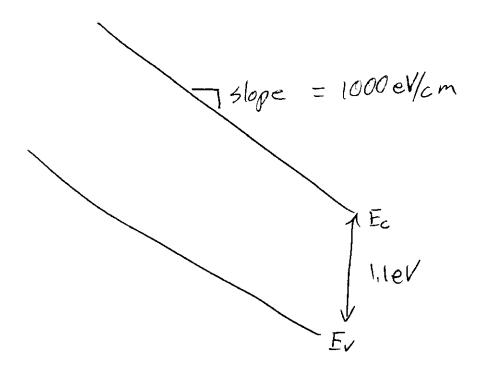
- 1.) (3-points) True of False. The energy bandgap can be considered the energy required to rip an electron out of the material into the vacuum where it conducts electricity.
- 2.) (3-points) (True) r False: The mobility is the low electric field slope of the drift velocity, in the region where the drift velocity is linearly proportional to the electric field.
- 3.) (3-points True or False: The product of [the density of states] and [1 -Fermi-distribution function] gives the hole concentration as a function of energy in the valence band.

X

- 4.) (3-points) True on False: If both electrons and holes are exposed to a built in field, as in a solar cell, the charges both move to the same side of the device accumulating on the anode (p-side).
- 5.) (3-points) True or False/ For a device with a high concentration of defect states or impurity states, the minority carrier lifetime will be very high.
- 6.) (3-points True or False: In a degenerately doped semiconductor, more than one hole can occupy a given state.
- 7.) (3-points) True or False: Larger bond strength results in higher energy bandgaps.
- 8.) (3-points) True or False: The Fermi-Dirac integral of order ½, the Fermi distribution function and the Boltzmann distribution function are all ways of describing the probability that a state is filled with an electron.
- 9.) (3-points) True or False: Auger recombination is only important at low current density or at low optical injection (low optical power).
- 10.)(3-points) (True of False: Impact ionization can increase a small current into a large current but is generally noisy current as the multiplication of charge is random and thus, stochastic.

Short Answer ("Plug and Chug"):

11.)(4-points) Sketch and label the energy band diagram of Silicon (1.1 eV bandgap) subjected to an electric field of 1000V/cm showing the conduction and valance bands and labeling the diagram with some indication of how one could derive the material is exposed to this particular electric field. Points deducted for lack of neatness, clarity and missing energy labels and numeric values.



For the following problems (11-12) use the following material parameters and <u>assuming total</u> ionization:

For InP:  $n_i=1.3e7 \text{ cm}^{-3}$  N<sub>D</sub>=1.8e13 cm<sup>-3</sup> donors N<sub>A</sub>=1.6e17 cm<sup>-3</sup> acceptors  $m_p^{+}=0.6m_o$  m<sub>n</sub><sup>+</sup>=0.08m<sub>o</sub> E<sub>G</sub>=1.344 eV Electron mobility,  $\mu_n = 900 \text{ cm}^2/\text{Vsec}$  Hole mobility,  $\mu_p = 120 \text{ cm}^2/\text{V-sec}$ Temperature=27 degrees C

12.)(5-points) Where is the fermi energy (relative to the valence band which is referenced to zero energy)?

$$P_{e}^{-1} \frac{NA - N_{o}}{2} + \sqrt{\frac{(Na - N_{o})^{2}}{4} + h_{i}^{-2}} = 1.6e17_{cm} = \frac{h_{i}^{2}}{P_{o}} = 1.06e-3 \quad E_{i}^{-1} = \frac{E_{i}}{2} + \frac{3}{4} \frac{kT}{k} \frac{k}{k} \left(\frac{m_{P}}{m_{A}}\right)$$

$$= 0.711 \text{ oV}$$

$$Several \quad Approaches$$

$$1) \quad P_{o}^{-1} h_{i}^{-1} e^{(E_{i}^{-1} - E_{f}^{-1})/kT}$$

$$2) \quad h_{o}^{-1} h_{i}^{-1} e^{(E_{f}^{-1} - E_{i}^{-1})/kT}$$

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$$1) \quad N_{v}^{-1} = 2.511 \times 10^{9} \left(\frac{m_{P}}{m_{O}}\right)^{2} = 1.16e19 \text{ GeV}^{-5}$$

$$E_{f}^{-1} e^{V}$$

$$E_{f}^{-1} e^{V}$$

$$E_{f}^{-1} e^{V}$$

$$0.109$$

14 +1

13.) (8-points) A 25 nm (1 nm = 1e-9 m) *diameter* x 500 nm long cylindrical semiconductor resistor is made from the semiconductor from problem 12 is biased on two opposing sides (longest dimension) with 0.9 volts. Determine <u>both</u> the electron and hole <u>currents</u> flowing in the device.

$$A = \left[ \begin{array}{c} 25e - 7cm \\ 2 \end{array} \right]^{2} T \qquad (1) \\ = 4,909e - 12 \ cm^{2} \qquad 1 = 5e \ fcm \\ P = 9^{\mu}pP^{\rho} \qquad Pn = 9^{\mu}n \ ho \\ fn = 6,57e18 \ R - cm \qquad 1 \\ R = 6,57e18 \ R - cm \qquad 1 \\ R = \frac{fn^{\perp}}{A} = 3,32 \ MD \qquad R = \frac{fn^{\perp}}{A} = 6,7e25 \ D \\ V \\ R_{p} = \left[ \begin{array}{c} I_{p} = 2,7e - 7A \\ = 0,27 \ MA \end{array} \right] \qquad In = \frac{V}{R} = 1.34e - 26 \ A \\ R = 0,27 \ MA \qquad 10 \end{array}$$

## Section 3 (more short answer)

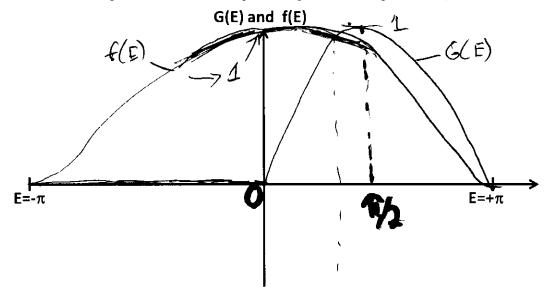
14.) (13-points total) The brilliant and humble Professor Doolittle has found a semiconductor that obeys new "Doolittian Physics". It is found the density of states of this material follows the function:

$$G(E) = \begin{cases} sin(E) \text{ for } 0 < E < \pi \\ 0 \text{ elsewhere} \end{cases}$$

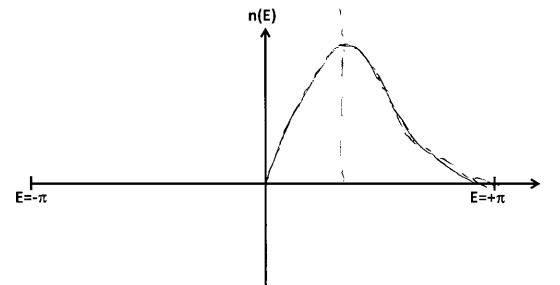
and the fermi distribution function for this new physics is:

$$f(E) = \frac{1}{2} [1 + \cos(E)] \text{ for } -\pi < E < \pi$$

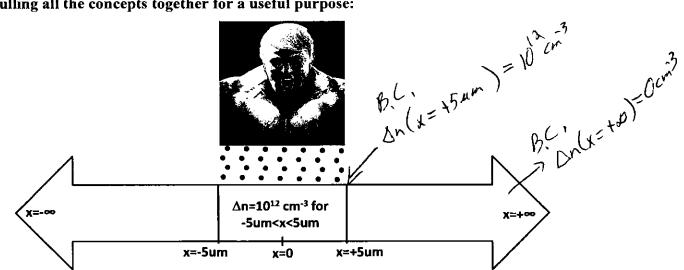
On the same Graph, sketch and label peak magnitudes and peak energies for G(E) and f(E).



Sketch (do not label magnitudes) of the electron concentration versus energy function n(E).



Pulling all the concepts together for a useful purpose:



14.) (40-points): A semi-infinite slab of GaN semiconductor is to be used as part of new nuclear battery known as a Betavoltaic device. The GaN extends from negative infinity to positive infinity as pictured and is to be considered in 1 dimension (x). The incredible Hulk walks into the room in 1994 and radiates extremely high energy nuclear particles that generate electron hole pairs in a process identical to that as if they originated from light ONLY in the region from -5 to +5 um. All other regions are considered in the dark. The resultant excess electron concentration from +5 to -5 um is uniform and equal to  $10^{12}$  cm<sup>-3</sup>. The semiconductor is doped p-type with an acceptor concentration of 6e15 cm<sup>-3</sup>, has an intrinsic concentration of 1e-14 cm<sup>-3</sup> and has a minority carrier lifetime of 5 nanoseconds. If the semiconductor is held at room temperature (27 degrees C), determine the minority carrier diffusion current density at all positions in the semiconductor ( $+\infty \ge x \ge -\infty$  um). Assume a minority carrier mobility of 1930.5 cm<sup>2</sup>/Vsec.

Given:	$0 = D_n \frac{d^2 \Delta n_p}{dx^2} - \frac{\Delta n_p}{\tau_n}$	General Solution is:	$\Delta n_p(x) = A e^{-\frac{x}{l_n}} + B e^{+\frac{x}{l_n}}$
Given:	$0 = D_n \frac{d^2 \Delta n_p}{dx^2} - \frac{\Delta n_p}{\tau_n} + G_L$	General Solution is: $\Delta n$	$f_p(x) = Ae^{-\frac{x}{L_n}} + Be^{+\frac{x}{L_n}} + G_L \tau_n$
	$0 = D_n \frac{d^2 \Delta n_p}{dx^2}$	General Solution is:	$\Delta n_{p}(x) = A + Bx$
Given:	$0 = D_n \frac{d^2 \Delta n_p}{dx^2} + G_L$	General Solution is:	$\Delta n_p(x) = Ax^2 + Bx + C$
Given:	$0 = D_n \frac{d^2 \Delta n_p}{dx^2} + G_{LO} f(x) \text{ Get}$	eneral Solution is: $\Delta n_p(x)$	$f(x) = \left[ -\frac{G_{LO}}{D_N} \iint f(x) dx^2 \right] + Bx + C$
	$\frac{d\Delta n_p}{dt} = -\frac{\Delta n_p}{\tau_n}$	General Solution is:	$\Delta n_p(t) = \Delta n_p(t=0)e^{-t/\tau_n}$
Given:	$0 = -\frac{\Delta n_p}{\tau_n} + G_L$	General Solution is:	$\Delta n_p = G_L \tau_n$

 $D_{h} = \mathcal{U}_{h} \frac{h_{h}T}{q}$   $= 1930.49 (0.0359) = 50 \text{ cm}^{2}/\text{sec} = 5.400$ Extra work can be done here, but clearly indicate which problem you are solving. X 25 Mm . Du(x) = A e - x / hn + Be + x/Ln BC. x = + 0 dulx=00)= A(0) + B00 ==> B=0  $\frac{5\mu m}{\Delta n(x=5\mu m)} = Ap - \frac{5}{5\mu m}$ BC: x=5 Am  $10^{12} = Ae^{-1}$ = A 0.36 78 A= 2,718 e 12 cm-3 XZ5mm: An(x)= 2.718 e12 cm3 e - X/5mm cm-3 by symmetry  $x \le -5$   $\Delta n(x) = 2.718 e12 cn^{-3} e^{+x/54m} cm^{-3}$  $-5 \ C \times = 5! \ \Delta n(x) = 10^{12} \ cm^{-3}$  $J_{n} = q D_{n} V_{n}$ = (1.6e-19) (50 cm<sup>2</sup>/sec) ( $\frac{2.718e12}{5 \times 10^{-4} cm} e^{-\chi/5 am}$ ) X75um;  $J_n = \begin{bmatrix} 43.48 \\ m A/m^2 \end{bmatrix} \begin{bmatrix} -x/5um \end{bmatrix}$  $X \sim -5um$ ;  $J_n = \begin{bmatrix} 43.48 \\ m A/m^2 \end{bmatrix} \begin{bmatrix} e^{+x/5um} \end{bmatrix}$ -5LX65:  $L_{n}=54m$  ISI  $f^{n}=0$ 

Extra work can be done here, but clearly indicate which problem you are solving.

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